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33082M237

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s): Yasuhiro Chouno, et al.

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Group Art Unit: To Be Assigned

Filed: : Herewith Examiner: To Be Assigned

For: SUBSTRATE PROCESSING CONTAINER

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Date: January 24, 2005

Sir:

Pursuant to the duty of disclosure under 37 C.F.R. 1.56, Applicants are enclosing an Information Disclosure Citation Form (PTO-1449) which lists the documents noted in the International Search Report (ISR). A copy of the ISR is being filed herewith.

It is respectfully requested that the cited documents be considered by the Examiner in the above-identified patent application and that the cited documents be made officially of record therein. It is further requested that a listing of the same appear on the face of any patent which may issue from this application.

Respectfully submitted, SMITH, GAMBRELL & RUSSELL, LLP

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FORM PTO-1		ATION DISCLOSU	RE STATEMENT	ATTY. DOCKET 33082M237		SERIAL NO.			
					Applicant Yasuhiro Chouno, et al.				
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			U.S. PATEN	T DOCU	 MENTS		<u> </u>		
*Examiner's Initials		DOCUMENT NUMBER	DATE		NAME	CLASS	SUB- CLASS	FILING DATE, IF APPROPRIATE	
	AA	4,465,201	8/14/84	Chalfa	ant, Jr.				

FOREIGN PATENT DOCUMENTS

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	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLAT YES	TION NO							
AE	2002-164410	6/7/02	Japan			Abstract								
AF	02-238616	9/20/90	Japan			Abstract								
AG	WO 94/17353	8/4/94	PCT											
AK	04-158511	6/1/92	Japan			Abstract								
AH	10-308348	11/17/98	Japan			Abstract								
AI	2000-018207	1/18/00	Japan			Abstract								
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OTHER INFORMATION (Including Author, Title, Date, Pertinent Pages, Etc.)

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EXAMINER:

DATE CONSIDERED:

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.